

Sauls Wharf House Crittens Road Great Yarmouth Norfolk NR31 0AG

| MCOT128064H1V-WM | 128 | x 64 | | | | | |
|------------------|------------|-------|------------------|--|--|--|--|
| Specification | | | | | | | |
| Version: 1 | | | Date: 04/06/2016 | | | | |
| | Revision | | | | | | |
| 1 | 01/06/2016 | First | Issue | | | | |

| Display F | Display Features | | | | |
|-----------------------|-------------------------|--------------|------------------|--|--|
| Resolution | 128 x 64 | | | | |
| Appearance | White on Black | | | | |
| Logic Voltage | 3V | | CoHS | | |
| Interface | Multi | | ompliant | | |
| Module Size | 60.50 x 37.00 x 2.15 mm | | | | |
| Operating Temperature | -40°C ~ +80°C | Box Quantity | Weight / Display | | |
| Construction | СОТ | | | | |

* - For full design functionality, please use this specification in conjunction with the SSD1309Z specification. (Provided Separately)

| Disp | ay Accessories | | Optional Variants | |
|-------------|---|----|-------------------|---------|
| Part Number | Description | AC | Appearance | Voltage |
| MPBV6 | FFC to cable. Supports up to 40 way. Any driver board that supports 1mm pitch SHDR-40V-S-B receptacle. | | | |
| MCIB12 | UC32 Breakout Board with SD card and LED back light driver. Used in conjunction with MPBV6. | | | |
| | | | | |

General Specification

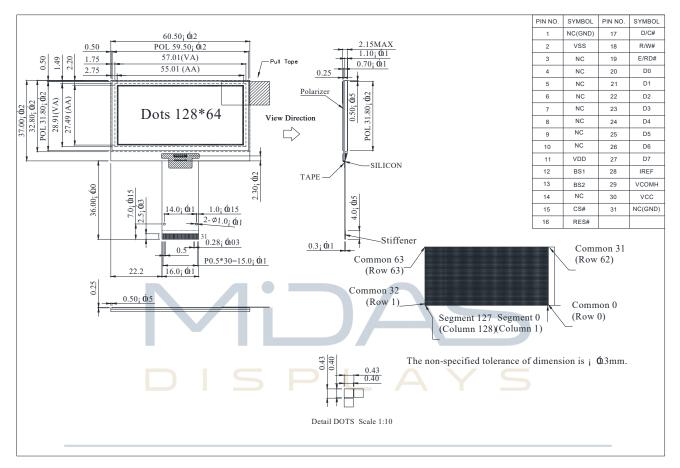
The Features is described as follow:

- Module dimension: 60.5 × 37.0 × 2.15 mm
- Active area: 55.01 × 27.49mm
- Dot Matrix: 128*64
- Dot size: 0.40 × 0.40 mm
- Dot pitch: 0.43 × 0.43 mm
- Display Mode : Passive Matrix
- Duty: 1/64 Duty
- Display Color: OLED , White
- Controller IC: SSD1309Z

Interface Pin Function

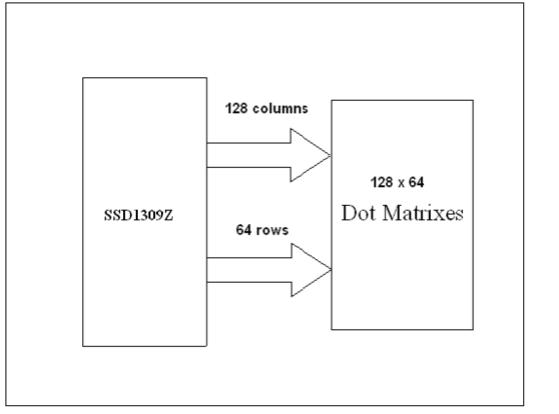
| Pin No. | Symbol | Function | | | | | | |
|---------|-------------------|---|---|---|--|--|--|--|
| 1 | NC(GND) | No connection (ground.) | | | | | | |
| 2 | Vss | Ground pin. It must be co | Ground pin. It must be connected to external ground. | | | | | |
| 3~10 | NC | No connection | | | | | | |
| 11 | Vdd | Power supply pin for core | e logic oper | ation | | | | |
| 12 | BS1 | MCU bus interface select described in the | ion pins. S | elect appropr | iate logic setting as | | | |
| | | following table. | | | - | | | |
| | | | BS1 | BS2 | | | | |
| | | 12C | 1 | 0 | | | | |
| 13 | BS2 | 4-wire Serial | 0 | 0 | | | | |
| - | 002 | 8-bit 68XX Parallel | 0 | 1 | | | | |
| | | 8-bit 80XX Parallel | 1 | 1 | | | | |
| | | Note (1) 0 is connected to VSS A S (2) 1 is connected to VDD | | | | | | |
| 14 | NC | No connection | | | | | | |
| 15 🕞 | € <u>C</u> \$#_ N | | his pin is the chip select input connecting to the MCU. The chip is enabled for MCU communication only when CS# is pulled OW (active | | | | | |
| 16 | RES# | This pin is reset signal in When the pin is pulled LC | LOW). This pin is reset signal input. When the pin is pulled LOW, initialization of the chip is executed. Keep this pin pull HIGH during normal operation. | | | | | |
| 17 | D/C# | This pin is Data/Comman When the pin is pulled HI data. When the pin is pulled LC command register. In I2C mode, this pin acts When 3-wire serial interfa VSS. For detail relationship to I Characteristics | GH, the dat OW, the dat as SA0 fo ace is selec | in connecting ta at D[7:0] w a at D[7:0] wi r slave addre ted, this pin r | vill be interpreted as ill be transferred to a ss selection. nust be connected to | | | |

| 18 | R/W# | This pin is read / write control input pin connecting to the MCU interface. When 6800 interface mode is selected, this pin will be used as Read/Write (R/W#) selection input. Read mode will be carried out when this pin is pulled HIGH and write mode when LOW. When 8080 interface mode is selected, this pin will be the Write (WR#) input. Data write operation is initiated when this pin is pulled LOW and the chip is |
|-------|---------|--|
| | | selected. When serial or I2C interface is selected, this pin must be connected to VSS. |
| 19 | E/RD# | This pin is MCU interface input. When 6800 interface mode is selected, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled HIGH and the chip is selected. When 8080 interface mode is selected, this pin receives the Read (RD#) signal. Read operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS. |
| 20~27 | D0~D7 | These pins are bi-directional data bus connecting to the MCU data bus. Unused pins are recommended to tie LOW. When serial interface mode is selected, D0 will be the serial clock input: SCLK; D1 will be the serial data input: SDIN and D2 should be kept NC. When I2C mode is selected, D2, D1 should be tied together and serve as SDAout, SDAin in application and D0 is the serial clock input, SCL. |
| 28 | IREF | This pin is the segment output current reference pin. IREF is supplied externally. A resistor should be connected between this pin and VSS to maintain the current around 10uA. Please refer to Figure 8-15 for the details of resistor value |
| 29 | VCOMH | COM signal deselected voltage level. A capacitor should be connected between this pin and VSS. |
| 30 | VCC | Power supply for panel driving voltage. This is also the most positive power voltage supply pin. |
| 31 | NC(GND) | No connection (ground.) |



Counter Drawing & Block Diagram

FUNCTION BLOCK DIAGRAM



*For more information, please refer to Application Note provided by T aa AÔ[{][} ^} o.

Absolute Maximum Ratings

| Parameter | Symbol | Min | Мах | Unit | Notes |
|----------------------------|--------|------|-----|------|-------|
| Supply Voltage for Logic | VDD | -0.3 | 4 | V | 1, 2 |
| Supply Voltage for Display | VCC | 0 | 15 | V | 1, 2 |
| Operating Temperature | TOP | -40 | +80 | °C | - |
| Storage Temperature | TSTG | -40 | +80 | °C | - |

Note 1: All the above voltages are on the basis of "VSS = 0V".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to Section 6 "Electrical Characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate

Electrical Characteristics

| Item | Symbol | Condition | Min | Тур | Max | Unit |
|-------------------------------------|--------|-----------|---------|-----|---------------|------|
| Supply Voltage for Logic | VDDA | NUFACTU | R 2.8 • | 3.0 | 3 .3_Y | V |
| Supply Voltage for Display | VCC | - | 12 | 13 | 15 | V |
| High Level Input | VIH | - | 0.8×VDD | - | VDD | V |
| Low Level Input | VIL | - | 0 | - | 0.2×VDD | V |
| High Level Output | VOH | - | 0.9×VDD | - | VDD | V |
| Low Level Input | VOL | - | 0 | - | 0.1×VDD | V |
| 50% Check Board operatir Current | ng | VCC =13V | 15 | 18 | 22 | mA |

Optical Characteristics

| Symbol | Condition | Min | Тур | Мах | Unit |
|-----------------------|--|--|---|---|--|
| (V)θ | - | 160 | - | - | deg |
| (H)φ | - | 160 | - | - | deg |
| CR | Dark | 2000:1 | - | - | - |
| T rise | - | - | 10 | - | μs |
| T fall | - | - | 10 | - | μs |
| l Board Brightness | | 70 | 90 | - | cd/m2 |
| | (CIE1931) | 0.26 | 0.28 | 0.30 | - |
| | (CIE1931) | 0.30 | 0.32 | 0.34 | - |
| | (V)θ (H)φ CR T rise T fall 3oard Brightness | (V)θ - (H)φ - CR Dark T rise - T fall - Board Brightness (CIE1931) | (V)θ - 160 (H)φ - 160 CR Dark 2000:1 T rise - - T fall - - Soard Brightness 70 0.26 | (V)θ - 160 - (H)φ - 160 - CR Dark 2000:1 - T rise - - 10 T fall - - 10 Soard Brightness 70 90 (CIE1931) 0.26 0.28 | (V)θ - 160 - - (H)φ - 160 - - CR Dark 2000:1 - - T rise - 10 - - T fall - - 10 - Soard Brightness 70 90 - (CIE1931) 0.26 0.28 0.30 |

DISPLAYS

OLED Lifetime

| ITEM | Conditions | Min | Тур | Remark |
|------------------------|--|------------|-----|--------|
| Operating Life Time | Ta=25°C / Initial 50% check board brightness Typical Value | 20,000 Hrs | - | Note |

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.

Reliability

Content of Reliability Test

| Environmenta Test Item | I Test Content of Test | Test Condition | Applicable |
|---|---|--|----------------|
| | | | Standard |
| High Temperature storage | Endurance test applying the high storage temperature for a long time. | 80 | |
| Low Temperature storage | Endurance test applying the low storage temperature for a long time. | -40 □ 240hrs | |
| High Temperature Operation | Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. | 80⊡ 240hrs | |
| Low Temperature Operation | Endurance test applying the electric stress under low temperature for a long time. | -40□ 240hrs | |
| High Temperature/ Humidity Storage | Endurance test applying the high temperature and high humidity storage for a long time. | 60□,90%RH 240hrs | 5 |
| Temperature Cycle | Endurance test applying the low and high temperature cycle. -40 25 80 30min 5min 30min 1 cycle | -40□/80□ 100 cycles | 5 |
| Mechanical Tes | st | | |
| Vibration test | Endurance test applying the vibration during transportation and using. | 10~22Hz→1.5mmp-p 22~500Hz→1.5G Total 0.5hr | <u>S</u> UPPLY |
| Shock test | Constructional and mechanical endurance test applying the shock during transportation. | 50G Half sin wave 11 ms 3 times of each direction | |
| Atmospheric pressure test | Endurance test applying the atmospheric pressure during transportation by air. | 115mbar 40hrs | |
| Others | | | |
| Static electricity test | Endurance test applying the electric stress to the terminal. | VS=±600V(contact), ±800v(air), RS=330Ω CS=150pF 10 times | |

*** Supply voltage for OLED system =Operating voltage at 25°C

Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within ± 50% of initial value.

APPENDIX:

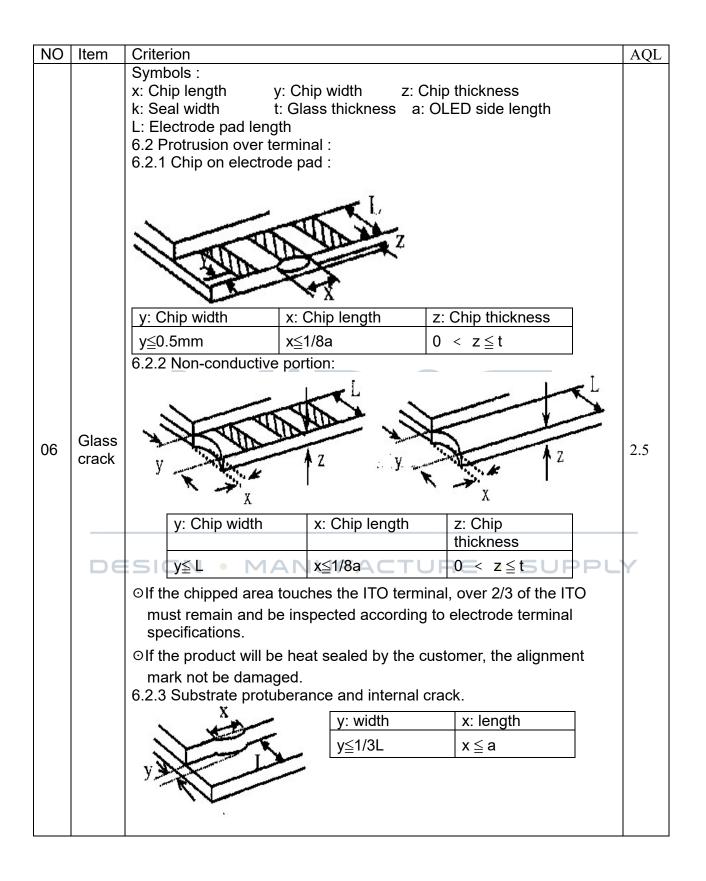
RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.

Inspection specification

| Electrical | 4 4 Minning stratt | | | | | AQL |
|--|--|---|--|--|--|---|
| Testing | 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. | | | | | |
| Black or white spots on OLED (display only) | 2.1 White and black spots on display □0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm. | | | | | |
| OLED black spots, white spots, contamina tion (non-displ ay) | | | | | | 2.5 |
| DESI | 3.2 Line type : (A | | | | • SUPPL | Y |
| | ★ | Length | | | • | |
| | | | ₩ | ≦0.02 | Accept no dense | |
| | → L +← | L≦3.0 | 0.0 |)2 < W≦0.03 | 2 | 2.5 |
| | | L≦2.5 | 0.0 |)3 < W≦0.05 | 2 | |
| | | | 0.0 |)5 < W | As round type | |
| Polarizer bubbles | judge using blac specifications, no to find, must che | k spot ot easy eck in | Φ 0.2 0.5 | ≦0.20 20 < Φ≦0.50 50 < Φ≦1.00 00 < Φ | Acceptable Q TY Accept no dense 3 2 0 | 2.5 |
| | white spots on OLED (display only) OLED black spots, contamina tion (non-displ ay) DESI | 1.4 No function of 1.5 Current cons 1.6 OLED viewin 1.7 Mixed produ 1.8 Contrast defectBlack or white spots on OLED (display only)2.1 White and bl three white or bla 2.2 Densely spatial 3mm.OLED black spots, contamina tion (non-display)3.1 Round type if following drawing $\Phi = (x + y) / 2$ $\Psi = (x + y) / 2$ DESI ay)3.2 Line type : (A $\mu = 1$ LPolarizer bubblesIf bubbles are vis judge using black specifications, no to find, must che | 1.4 No function or no displation of the spots on OLED (display only)1.4 No function or no displation of the spots on OLED (display only)0LED (display only)3.1 Round type : As following drawing spots, white spots, contamina tion (non-display)0LED (non-display)3.2 Line type : (As following law)0LED (Length of the spots)3.2 Line type : (As following law)0LES (Length of the spots)1.4 No function or no display only)0LED (Length of the spots)1.4 No function or no display only)0LED (Length of the spots)3.1 Round type : As following drawing only)0LED (Length of the spots)1.4 No function of the spots)0LED (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)0LES (Length of the spots)1.4 No function of the spots)1.4 No function of the spots)1.4 No function of the spots)1.5 No function of the spots)1.4 No function of the spots)1.5 No function of the spots)1.4 No function of the spots)1.6 No function of the spots)1.4 No function of the spots)1.6 No function of the spots)1.4 No function of the spots)1.7 No function of the spots)1.4 No functi | 1.4 No function or no display. 1.5 Current consumption exce 1.6 OLED viewing angle defect 1.7 Mixed product types. 1.8 Contrast defect.Black or white spots on OLED (display only)2.1 White and black spots on of three white or black spots press 2.2 Densely spaced: No more 3mm.OLED black spots, contamina tion (non-display)3.1 Round type : As following drawing $\Phi=(x + y)/2$ White spots, contamina tion (non-display)3.2 Line type : (As following drawing $\Phi=(x + y)/2$ Image: Spots, contamina tion (non-display)3.2 Line type : (As following drawing $\Psi=$ IImage: Spots, contamina tion (non-display)3.2 Line type : (As following drawing $\Psi=$ IImage: Spots, contamina tion | 1.4 No function or no display. 1.5 Current consumption exceeds product sp 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect.Black or white spots on OLED (display only)2.1 White and black spots on display $\bigcirc 0.25n$ three white or black spots present. 2.2 Densely spaced: No more than two spots 3mm.OLED (display only)3.1 Round type : As following drawing $\Phi=(x + y) / 2$ white spots, contamina tion (non-displ ay)SIZE $\Phi \le 0.10$ $0.10 < \Phi \le 0.2$ $0.20 < \Phi \le 0.2$ $0.25 < \Phi$ DESI3.2 Line type : (As following drawing) $\Psi=$ L \bullet Length $\Psi intheU \le 0.03 < W \le 0.03L \le 2.50.03 < W \le 0.03L \le 2.50.03 < W \le 0.03L \le 2.50.03 < W \le 0.03U \le 0.200.20 < 4 \le 0.200.20 < 4 \le 0.200.20 < 0.25 < 0PolarizerbubblesIf bubbles are visible,judge using black spotspecifications, not easyto find, must check inSize \Phi\Phi \le 0.200.20 < \Phi \le 0.50$ | 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect.Black or white spots on OLED (display only)2.1 White and black spots on display 0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm.OLED (display only)3.1 Round type : As following drawing $\Phi=(x + y) / 2$ SIZEAcceptable Q TYWhite spots, contamina tion (non-displ ay)3.2 Line type : (As following drawing)SIZEAccept no denseMite spots, contamina tion (non-displ ay)3.2 Line type : (As following drawing)SIZEAccept no denseDescriptionT $\Psi = 0.10$ Accept no denseDescriptionSize Φ 0DescriptionSize Φ 0DescriptionSize Φ Acceptable Q TY $$ DescriptionSize Φ Acceptable Q TY $\Phi \le 0.20$ DescriptionSize Φ Accep |

| NO | Item | Criterion | | | AQL |
|----|------------------|--|------------------------|------------------------------------|-----|
| 05 | Scratches | Follow NO.3 OLED blac | k spots, white spot | s, contamination | |
| | | | lass thickness a: | Chip thickness OLED side length | |
| | | 6.1 General glass chip : 6.1.1 Chip on panel surf | ace and crack betw | veen panels: | |
| | | | | y 1 | |
| | | z: Chip thickness y: | Chip width | x: Chip length | |
| | | | ot over viewing | x≦1/8a | |
| 06 | Chipped glass | | rea ot exceed 1/3k | x≦1/8a | 2.5 |
| | 9 | olf there are 2 or more o | chips, x is total lend | | |
| | | | | Y S' | |
| | | 6.1.2 Corner crack: | | | |
| | | | ¢У | | |
| | DCCI | NAME OF | r T | E • SUPPL | |
| | DESI | | | | Y |
| | | | | | |
| | | | Chip width | x: Chip length | |
| | | | ot over viewing rea | x≦1/8a | |
| | | 1/2t < z≦2t | ot exceed 1/3k | x≦1/8a | |
| | | ⊙If there are 2 or more o | chips, x is the total | length of each chip. | |
| | | | | | |



| NO | Item | Criterion | AQL | |
|----|-----------------------|---|--|--|
| 07 | Cracked glass | The OLED with extensive crack is not acceptable. | | |
| 08 | Backlight elements | 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using OLED spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. | | |
| 09 | Bezel | 9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications. | | |
| 10 | PCB, COB | 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. 10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down. | 2.5 2.5 0.65 2.5 0.65 0.65 2.5 | |
| 11 | Soldering | 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. | 2.5 2.5 2.5 0.65 | |

| NO | Item | Criterion | AQL |
|----|-----------------------|---|------|
| | | 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. | 2.5 |
| | | 12.2 No cracks on interface pin (OLB) of TCP. | 0.65 |
| | | 12.3 No contamination, solder residue or solder balls on | 2.5 |
| | | product. | 2.5 |
| | | 12.4 The IC on the TCP may not be damaged, circuits. | 2.5 |
| | | 12.5 The uppermost edge of the protective strip on the | |
| 10 | General appearance | interface pin must be present or look as if it cause the interface pin to sever. | 2.5 |
| 12 | | 12.6 The residual rosin or tin oil of soldering (component or | 2.5 |
| | | chip component) is not burned into brown or black color. | 0.65 |
| | | 12.7 Sealant on top of the ITO circuit has not hardened. | 0.65 |
| | | 12.8 Pin type must match type in specification sheet. | 0.65 |
| | | 12.9 OLED pin loose or missing pins. | |
| | | 12.10 Product packaging must the same as specified on packaging specification sheet. | 0.65 |
| | | 12.11 Product dimension and structure must conform to | |
| | | product specification sheet. | |
| | | | |

DISPLAYS

| Check Item | Classification | Criteria |
|--|------------------|---------------------------|
| No Display | Major | |
| Missing Line | Major | |
| Pixel Short | Major | |
| Darker Short | Major | |
| DESIGN Wrong Display | MANUFA Major | |
| Un-uniform B/A x 100% < 70% A/C x 100% < 70% | Major | A Normal B Light Fixed |

Precautions in use of OLED Modules

- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, modify its shape or change the components of OLED display module.
- (3) Don't disassemble the OLED display module.
- (4) Don't operate it above the absolute maximum rating.
- (5) Don't drop, bend or twist OLED display module.
- (6) Soldering: only to the I/O terminals.
- (7) Storage: please storage in anti-static electricity container and clean environment.
- (8) It's pretty common to use "Screen Saver" to extend the lifetime and Don't use fix information for long time in real application.
- (9) Don't use fixed information in OLED panel for long time, that will extend "screen burn" effect time..
- (10) T aaæ has the right to change the passive components, including R2and R3 adjust resistors. (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.)

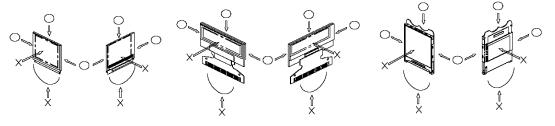
(11) T a are have the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, T are have the right to modify the version.)

1. Handling Precautions

- (1) Since the display panel is being made of glass, do not apply mechanical impacts such us dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged and be careful not to apply pressure to these sections.
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched. Please be careful when handling the OLED display module.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage of by using following adhesion tape.
- * Scotch Mending Tape No. 810 or an equivalent

Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent Also, pay attention that the following liquid and solvent may spoil the polarizer:

- * Water
- * Ketone
- * Aromatic Solvents
- (6) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts. These stresses will influence the display performance. Also, secure sufficient rigidity for the outer cases.



- (7) Do not apply stress to the LSI chips and the surrounding molded sections.
- (8) Do not disassemble nor modify the OLED display module.
- (9) Do not apply input signals while the logic power is off.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
- * Be sure to make human body grounding when handling OLED display modules.
- * Be sure to ground tools to use or assembly such as soldering irons.
- * To suppress generation of static electricity, avoid carrying out assembly work under dry environments.
- * Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.
- (11) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (12) If electric current is applied when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful to avoid the above.

2. Storage Precautions

- (1) When storing OLED display modules, put them in static electricity preventive bags avoiding exposure to direct sun light nor to lights of fluorescent lamps. And, also, avoiding high temperature and high humidity environment or low temperature (less than 0°C) environments.(We recommend you to store these modules in the packaged state when they were shipped from T aae. At that time, be careful not to let water drops adhere to the packages or bags nor let dewing occur with them.
- (2) If electric current is applied when water drops are adhering to the surface of the OLED display module, when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful about the above.

11.3 Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, panel damage may be happen.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specifications and, at the same time, to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD). (Recommend value: 0.5A)

(4) Pay sufficient attention to avoid occurrence of mutual noise interference with the neighboring devices.

- (5) As for EMI, take necessary measures on the equipment side basically.
- (6) When fastening the OLED display module, fasten the external plastic housing section.
- (7) If power supply to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module. Connection (contact) to any other potential than the above may lead to rupture of the IC.